# PCTEST ENGINEERING LABORATORY, INC.

7185 Oakland Mills Road, Columbia, MD 21046 USA Tel. 410.290.6652 / Fax 410.290.6654 http://www.pctestlab.com



# MEASUREMENT REPORT FCC Part 22, 24, & 27 LTE

**Applicant Name:** 

Samsung Electronics Co., Ltd. 129, Samsung-ro, Yeongtong-gu, Suwon-si Gyeonggi-do, 16677, Korea

**Date of Testing:** 4/19/2017-5/4/2017 Test Site/Location:

PCTEST Lab., Columbia, MD, USA

**Test Report Serial No.:** 1M1704170148-03.A3L

FCC ID: A3LSMJ330F

APPLICANT: SAMSUNG ELECTRONICS CO., LTD.

**Application Type:** Certification

**FCC Classification:** PCS Licensed Transmitter Held to Ear (PCE)

FCC Rule Part(s): §2; §22; §24; §27

**Test Procedure(s):** ANSI/TIA-603-D-2010, KDB 971168 D01 v02r02

**EUT Type:** Portable Handset

Model: SM-J330F/DS

SM-J330F Additional Model(s):

**Test Device Serial No.:** identical prototype [S/N: 03396, 03370, 13860]

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.





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Randy Ortanez President

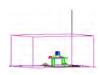


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# MEASUREMENT REPORT



FCC Part 22, 24, & 27

# §2.1033 General Information

APPLICANT: Samsung Electronics Co., Ltd.

APPLICANT ADDRESS: 129, Samsung-ro,

Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea

**TEST SITE:** PCTEST ENGINEERING LABORATORY, INC.

TEST SITE ADDRESS: 7185 Oakland Mills Road, Columbia, MD 21045 USA

 FCC RULE PART(S):
 \$2; \$22; \$24; \$27

 BASE MODEL:
 SM-J330F/DS

 FCC ID:
 A3LSMJ330F

FCC CLASSIFICATION: PCS Licensed Transmitter Held to Ear (PCE)

FREQUENCY TOLERANCE: ±0.00025 % (2.5 ppm)

**Test Device Serial No.:** 03396, 03370, 13860 ☐ Production ☐ Engineering

**DATE(S) OF TEST:** 4/19/2017-5/4/2017 **TEST REPORT S/N:** 1M1704170148-03.A3L

# **Test Facility / Accreditations**

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.

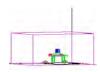
- PCTEST facility is an FCC registered (PCTEST Reg. No. 159966) test facility with the site description report on file and has met all the requirements specified in Section 2.948 of the FCC Rules and Industry Canada (2451B-1).
- PCTEST Lab is accredited to ISO 17025 by U.S. National Institute of Standards and Technology (NIST) under the National Voluntary Laboratory Accreditation Program (NVLAP Lab code: 100431-0) in EMC, FCC and Telecommunications.
- PCTEST Lab is accredited to ISO 17025-2005 by the American Association for Laboratory Accreditation (A2LA) in Specific Absorption Rate (SAR) testing, Hearing Aid Compatibility (HAC) testing, CTIA Test Plans, and wireless testing for FCC and Industry Canada Rules.
- PCTEST Lab is a recognized U.S. Conformity Assessment Body (CAB) in EMC and R&TTE (n.b. 0982) under the U.S.-EU Mutual Recognition Agreement (MRA).
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC Guide 65 by the American National Standards Institute (ANSI) in all scopes of FCC Rules and Industry Canada Standards (RSS).
- PCTEST facility is an IC registered (2451B-1) test laboratory with the site description on file at Industry Canada.
- PCTEST is a CTIA Authorized Test Laboratory (CATL) for AMPS, CDMA, and EvDO wireless devices and for Over-the-Air (OTA) Antenna Performance testing for AMPS, CDMA, GSM, GPRS, EGPRS, UMTS (W-CDMA), CDMA 1xEVDO, and CDMA 1xRTT.





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# **MEASUREMENT REPORT**



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			ERP/	EIRP		
Mode	FCC Rule Part	Tx Frequency (MHz)	Max. Pow er (W)	Max. Pow er (dBm)	Emission Designator	Modulation
LTE Band 17	27	706.5 - 713.5	0.066	18.20	4M52G7D	QPSK
LTE Band 17	27	706.5 - 713.5	0.050	16.95	4M51W7D	16QAM
LTE Band 17	27	709 - 711	0.070	18.47	8M96G7D	QPSK
LTE Band 17	27	709 - 711	0.043	16.31	8M97W7D	16QAM
LTE Band 5	22H	824.7 - 848.3	0.097	19.88	1M14G7D	QPSK
LTE Band 5	22H	824.7 - 848.3	0.078	18.93	1M13W7D	16QAM
LTE Band 5	22H	825.5 - 847.5	0.094	19.71	2M74G7D	QPSK
LTE Band 5	22H	825.5 - 847.5	0.074	18.72	2M73W7D	16QAM
LTE Band 5	22H	826.5 - 846.5	0.098	19.91	4M52G7D	QPSK
LTE Band 5	22H	826.5 - 846.5	0.076	18.81	4M53W7D	16QAM
LTE Band 5	22H	829 - 844	0.096	19.82	9M02G7D	QPSK
LTE Band 5	22H	829 - 844	0.076	18.83	9M01W7D	16QAM
LTE Band 4	27	1710.7 - 1754.3	0.231	23.64	1M13G7D	QPSK
LTE Band 4	27	1710.7 - 1754.3	0.186	22.69	1M13W7D	16QAM
LTE Band 4	27	1711.5 - 1753.5	0.239	23.79	2M74G7D	QPSK
LTE Band 4	27	1711.5 - 1753.5	0.189	22.76	2M74W7D	16QAM
LTE Band 4	27	1712.5 - 1752.5	0.377	25.76	4M52G7D	QPSK
LTE Band 4	27	1712.5 - 1752.5	0.305	24.85	4M53W7D	16QAM
LTE Band 4	27	1715 - 1750	0.259	24.14	8M98G7D	QPSK
LTE Band 4	27	1715 - 1750	0.194	22.89	9M02W7D	16QAM
LTE Band 4	27	1717.5 - 1747.5	0.261	24.16	13M5G7D	QPSK
LTE Band 4	27	1717.5 - 1747.5	0.243	23.85	13M5W7D	16QAM
LTE Band 4	27	1720 - 1745	0.290	24.63	18M0G7D	QPSK
LTE Band 4	27	1720 - 1745	0.235	23.70	17M9W7D	16QAM
LTE Band 2	24E	1850.7 - 1909.3	0.216	23.34	1M13G7D	QPSK
LTE Band 2	24E	1850.7 - 1909.3	0.172	22.36	1M14W7D	16QAM
LTE Band 2	24E	1851.5 - 1908.5	0.115	20.62	2M75G7D	QPSK
LTE Band 2	24E	1851.5 - 1908.5	0.099	19.96	2M73W7D	16QAM
LTE Band 2	24E	1852.5 - 1907.5	0.121	20.84	4M54G7D	QPSK
LTE Band 2	24E	1852.5 - 1907.5	0.090	19.55	4M52W7D	16QAM
LTE Band 2	24E	1855 - 1905	0.246	23.91	9M01G7D	QPSK
LTE Band 2	24E	1855 - 1905	0.178	22.52	9M02W7D	16QAM
LTE Band 2	24E	1857.5 - 1902.5	0.271	24.33	13M5G7D	QPSK
LTE Band 2	24E	1857.5 - 1902.5	0.212	23.26	13M5W7D	16QAM
LTE Band 2	24E	1860 - 1900	0.282	24.50	18M0G7D	QPSK
LTE Band 2	24E	1860 - 1900	0.217	23.37	18M0W7D	16QAM

**EUT Overview** 

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### 1.0 INTRODUCTION

# 1.1 Scope

Measurement and determination of electromagnetic emissions (EME) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Industry Canada Certification and Engineering Bureau.

# 1.2 Testing Facility

The map below shows the location of the PCTEST LABORATORY, its proximity to the FCC Laboratory, the Columbia vicinity, the Baltimore-Washington Internt'I (BWI) airport, the city of Baltimore and the Washington, DC area. (See Figure 1-1).

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The site coordinates are 39° 10'23" N latitude and 76° 49'50" W longitude. The facility is 0.4 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. The detailed description of the measurement facility was found to be in compliance with the requirements of § 2.948 according to ANSI C63.4-2014 on January 22, 2015.

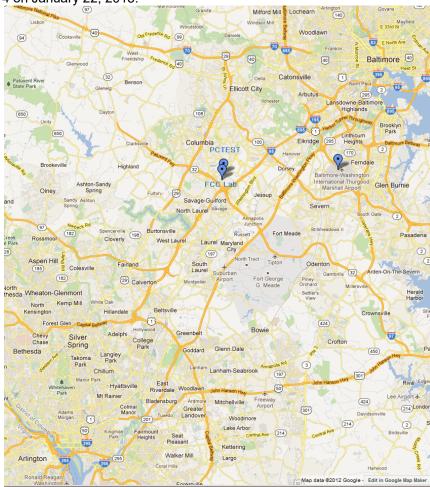


Figure 1-1. Map of the Greater Baltimore and Metropolitan Washington, D.C. area

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# 2.0 PRODUCT INFORMATION

# 2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSMJ330F**. The test data contained in this report pertains only to the emissions due to the EUT's LTE function.

# 2.2 Device Capabilities

This device contains the following capabilities:

850/1900 GSM/GPRS/EDGE, 850/1700/1900 WCDMA/HSPA, Multi-band LTE, 802.11b/g/n WLAN, Bluetooth (1x, EDR, LE)

# 2.3 Test Configuration

The EUT was tested per the guidance of ANSI/TIA-603-D-2010 and KDB 971168 D01 v02r02. See Section 7.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

# 2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

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#### **DESCRIPTION OF TESTS** 3.0

#### 3.1 **Measurement Procedure**

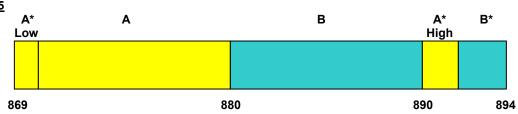
The measurement procedures described in the document titled "Land Mobile FM or PM – Communications Equipment - Measurements and Performance Standards" (ANSI/TIA-603-D-2010) and "Procedures for Compliance Measurement of the Fundamental Emission Power of Licensed Wideband (> 1 MHz) Digital Transmission Systems" (KDB 971168 D01 v02r02) were used in the measurement of the EUT.

#### 3.2 Block A Frequency Range §27.5(c)

698-746 MHz band. The following frequencies are available for licensing pursuant to this part in the 698-746 MHz band: (1) Three paired channel blocks of 12 megahertz each are available for assignment as follows:

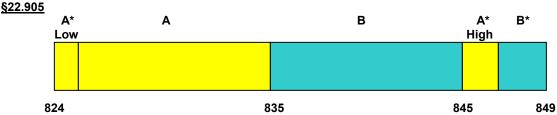
Block A: 698-704 MHz and 728-734 MHz; Block B: 704-710 MHz and 734-740 MHz; and Block C: 710-716 MHz and 740-746 MHz.

#### 3.3 **Cellular - Base Frequency Blocks** §22.905



BLOCK 1: 869 - 880 MHz (A\* Low + A) BLOCK 3: 890 - 891.5 MHz (A\* High) BLOCK 2: 880 - 890 MHz (B) BLOCK 4: 891.5 - 894 MHz (B\*)

#### 3.4 **Cellular - Mobile Frequency Blocks**

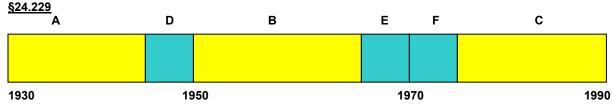


BLOCK 1: 824 - 835 MHz (A\* Low + A) BLOCK 3: 845 - 846.5 MHz (A\* High) BLOCK 4: 846.5 - 849 MHz (B\*) BLOCK 2: 835 - 845 MHz (B)

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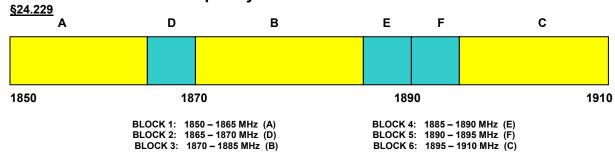




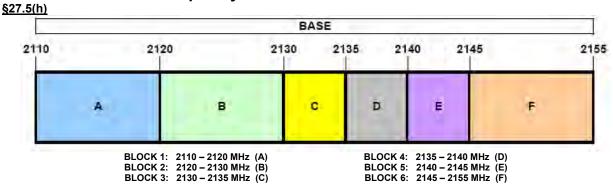


BLOCK 1: 1930 – 1945 MHz (A) BLOCK 4: 1965 – 1970 MHz (E) BLOCK 2: 1945 – 1950 MHz (D) BLOCK 5: 1970 – 1975 MHz (F) BLOCK 3: 1950 – 1965 MHz (B) BLOCK 6: 1975 – 1990 MHz (C)

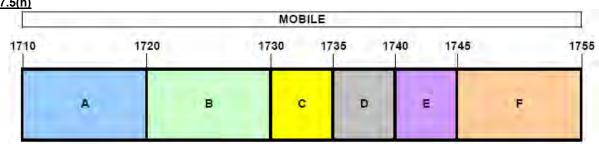
# 3.6 PCS - Mobile Frequency Blocks



# 3.7 AWS - Base Frequency Blocks



# 3.8 AWS - Mobile Frequency Blocks §27.5(h)



BLOCK 1: 1710 – 1720 MHz (A) BLOCK 4: 1735 – 1740 MHz (D) BLOCK 2: 1720 – 1730 MHz (B) BLOCK 5: 1740 – 1745 MHz (E) BLOCK 3: 1730 – 1735 MHz (C) BLOCK 6: 1745 – 1755 MHz (F)

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# 3.9 Radiated Power and Radiated Spurious Emissions §22.1053 §22.913(a.2) §22.917(a) §24.232(c) §24.238(a) §27.50(c.10) §27.50(d.4) §27.53(g) §27.53(h)

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Figure 5.7 of Clause 5 in ANSI C63.4-2014. Absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections for measurements above 1GHz. For measurements below 1GHz, the absorbers are removed. A raised turntable is used for radiated measurement. The turn table is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. A 72.4cm high PVC support structure is placed on top of the turntable. A 3" (~7.6cm) sheet of high density polystyrene is used as the table top and is placed on top of the PVC supports to bring the total height of the table to 80cm.

The equipment under test was transmitting while connected to its integral antenna and is placed on a turntable 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Radiated power levels are also investigated with the receive antenna horizontally and vertically polarized. The maximized power level is recorded using the spectrum analyzer "Channel Power" function with the integration band set to the emissions' occupied bandwidth, a RMS detector, RBW = 100kHz, VBW = 300kHz, and a 1 second sweep time over a minimum of 10 sweeps, per the guidelines of KDB 971168 D01 v02r02.

Per the guidance of ANSI/TIA-603-D-2010, a half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

Where,  $P_d$  is the dipole equivalent power,  $P_g$  is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to  $P_{q [dBm]}$  – cable loss  $f_{dBl}$ .

The calculated  $P_d$  levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log<sub>10</sub>(Power [Watts]).

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# 4.0 MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014. All measurement uncertainty values are shown with a coverage factor of k=2 to indicate a 95% level of confidence. The measurement uncertainty shown below meets or exceeds the  $U_{\text{CISPR}}$  measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Contribution	Expanded Uncertainty (±dB)
Conducted Bench Top Measurements	1.13
Radiated Disturbance (<1GHz)	4.98
Radiated Disturbance (>1GHz)	5.07
Radiated Disturbance (>18GHz)	5.09

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#### TEST EQUIPMENT CALIBRATION DATA 5.0

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST). Measurements antennas used during testing were calibrated in accordance to the requirements of ANSI C63.5-2006.

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	LTx3	Licensed Transmitter Cable Set	7/12/2016	Annual	7/12/2017	N/A
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	7/11/2016	Annual	7/11/2017	RE1
Agilent	N9020A	MXA Signal Analyzer	10/28/2016	Annual	10/28/2017	US46470561
Emco	3115	Horn Antenna (1-18GHz)	3/10/2016	Biennial	3/10/2018	9704-5182
Espec	ESX-2CA	Environmental Chamber	4/11/2017	Annual	4/11/2018	17620
ETS Lindgren	3160-09	18-26.5 GHz Standard Gain Horn	8/28/2016	Biennial	8/28/2018	135427
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	4/26/2016	Biennial	4/26/2018	128338
K&L	11SH10-3075/U18000	High Pass Filter	7/11/2016	Annual	7/11/2017	11SH10-3075/U18000-2
K&L	13SH10-1000/U1000	N Type High Pass Filter	7/6/2016	Annual	7/6/2017	13SH10-1000/U1000-1
Mini-Circuits	PWR-SENS-4RMS	USB Power Sensor	3/27/2017	Annual	3/24/2018	11210140001
Mini-Circuits	SSG-4000HP	USB Synthesized Signal Generator	N/A		11208010032	
Mini-Circuits	TVA-11-422	RF Power Amp		N/A		QA1303002
PCTEST	-	EMC Switch System	7/11/2016	Annual	7/11/2017	NM1
PCTEST	-	EMC Switch System	7/6/2016	Annual	7/6/2017	NM2
Rohde & Schwarz	CMW500	Radio Communication Tester	10/20/2016	Annual	10/20/2017	100976
Rohde & Schwarz	ESU40	EMI Test Receiver (40GHz)	7/15/2016	Annual	7/15/2017	100348
Rohde & Schwarz	TS-PR18	1-18 GHz Pre-Amplifier	7/11/2016	Annual	7/11/2017	100071
Rohde & Schwarz	TS-PR26	18-26.5 GHz Pre-Amplifier	6/7/2016	Annual	6/7/2017	100040
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Rx	3/30/2016	Biennial	3/30/2018	9105-2403
Seekonk	NC-100	Torque Wrench 5/16", 8" lbs	3/2/2016	Biennial	3/2/2018	N/A
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	3/14/2016	Biennial	3/14/2018	A051107
ETS Lindgren	3117	1-18 GHz DRG Horn (Medium)	4/26/2016	Biennial	4/26/2018	125518
Schwarzbeck	UHA 9105	Dipole Antenna	8/26/2016	Biennial	8/26/2017	2696

Table 5-1. Test Equipment

### Notes:

- 1. For equipment listed above that has a calibration date or calibration due date that falls within the test date range, care was taken to ensure that this equipment was used after the calibration date and before the calibration due date.
- 2. Equipment with a calibration date of "N/A" shown in this list was not used to make direct calibrated measurements.

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# **SAMPLE CALCULATIONS**

### **Emission Designator**

### **QPSK Modulation**

Emission Designator = 8M62G7D

LTE BW = 8.62 MHzG = Phase Modulation 7 = Quantized/Digital Info D = Data transmission, telemetry, telecommand

### **16QAM Modulation**

Emission Designator = 8M45W7D

LTE BW = 8.45 MHzW = Amplitude/Angle Modulated 7 = Quantized/Digital Info D = Data transmission, telemetry, telecommand

# Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2<sup>nd</sup> Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was -81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of -81.0 dBm on the spectrum analyzer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of -30.9 dBm yielding -24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm - (-24.80).

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# 7.0 TEST RESULTS

# 7.1 Summary

Company Name: <u>Samsung Electronics Co., Ltd.</u>

FCC ID: <u>A3LSMJ330F</u>

FCC Classification: PCS Licensed Transmitter Held to Ear (PCE)

Mode(s): LTE

FCC Part Section(s)	Test Description	Test Limit	Test Condition	Result	Reference
2.1049	Occupied Bandwidth	N/A		PASS	Section 7.2
2.1051 22.917(a) 24.238(a) 27.53(g) 27.53(h)	Out of Band Emissions	> 43 + 10log <sub>10</sub> (P[Watts]) at Band Edge and for all out-of-band emissions		PASS	Section 7.3, 7.4
24.232(d)	Peak-Average Ratio	< 13 dB	CONDUCTED	PASS	Section 7.5
2.1046	Transmitter Conducted Output Power	N/A		PASS	See RF Exposure Report
2.1055. 22.355 24.235 27.54	Frequency Stability	< 2.5 ppm (Part 22) and fundamental emissions stay within authorized frequency block (Part 24, 27)		PASS	Section 7.8
22.913(a.2)	Effective Radiated Power (Band 5)	< 7 Watts max. ERP		PASS	Section 7.6
27.50(c.10)	Effective Radiated Power (Band 17)	< 3 Watts max. ERP		PASS	Section 7.6
24.232(c)	Equivalent Isotropic Radiated Power (Band 2)	< 2 Watts max. EIRP	RADIATED	PASS	Section 7.6
27.50(d.4)	Equivalent Isotropic Radiated Power (Band 4)	< 1 Watts max. EIRP		PASS	Section 7.6
2.1053 22.917(a) 24.238(a) 27.53(g) 27.53(h)	Undesirable Emissions	> 43 + 10log <sub>10</sub> (P[Watts]) for all out-of-band emissions		PASS	Section 7.7

### Table 7-1. Summary of Test Results

### Notes:

- 1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions
- 2) The analyzer plots (Sections 7.2, 7.3, 7.4, 7.5) were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
- 3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
- 4) For conducted spurious emissions, automated test software was used to measure emissions and capture the corresponding plots necessary to show compliance. The measurement software utilized is PCTEST "LTE Automation," Version 4.5.

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# 7.2 Occupied Bandwidth §2.1049

### **Test Overview**

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. All modes of operation were investigated and the worst case configuration results are reported in this section.

### **Test Procedure Used**

KDB 971168 D01 v02r02 - Section 4.2

### **Test Settings**

- The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
- 2. RBW = 1 5% of the expected OBW
- 3. VBW  $\geq$  3 x RBW
- 4. Detector = Peak
- 5. Trace mode = max hold
- 6. Sweep = auto couple
- 7. The trace was allowed to stabilize
- 8. If necessary, steps 2-7 were repeated after changing the RBW such that it would be within 1-5% of the 99% occupied bandwidth observed in Step 7

### **Test Setup**

The EUT and measurement equipment were set up as shown in the diagram below.

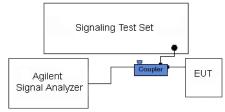


Figure 7-1. Test Instrument & Measurement Setup

# **Test Notes**

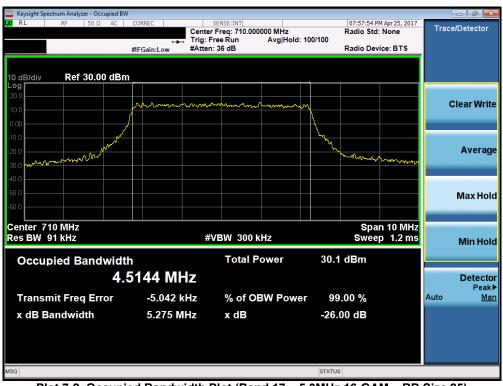
None.

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Plot 7-1. Occupied Bandwidth Plot (Band 17 - 5.0MHz QPSK - RB Size 25)



Plot 7-2. Occupied Bandwidth Plot (Band 17 - 5.0MHz 16-QAM - RB Size 25)

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Plot 7-3. Occupied Bandwidth Plot (Band 17 - 10.0MHz QPSK - RB Size 50)



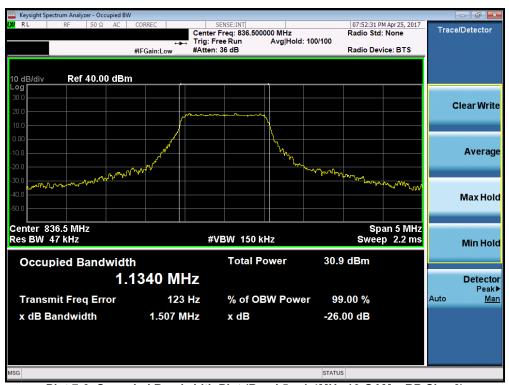
Plot 7-4. Occupied Bandwidth Plot (Band 17 - 10.0MHz 16-QAM - RB Size 50)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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Plot 7-5. Occupied Bandwidth Plot (Band 5 - 1.4MHz QPSK - RB Size 6)



Plot 7-6. Occupied Bandwidth Plot (Band 5 – 1.4MHz 16-QAM – RB Size 6)

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Plot 7-7. Occupied Bandwidth Plot (Band 5 - 3.0MHz QPSK - RB Size 15)



Plot 7-8. Occupied Bandwidth Plot (Band 5 – 3.0MHz 16-QAM – RB Size 15)

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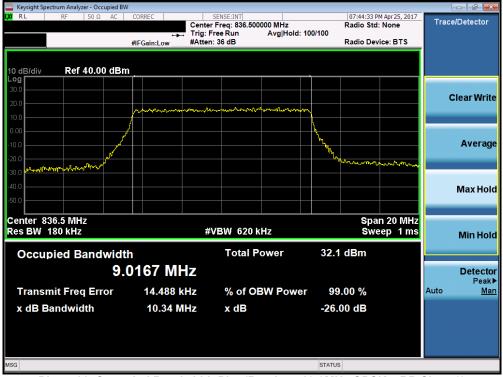
Plot 7-9. Occupied Bandwidth Plot (Band 5 - 5.0MHz QPSK - RB Size 25)



Plot 7-10. Occupied Bandwidth Plot (Band 5 - 5.0MHz 16-QAM - RB Size 25)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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Plot 7-11. Occupied Bandwidth Plot (Band 5 - 10.0MHz QPSK - RB Size 50)



Plot 7-12. Occupied Bandwidth Plot (Band 5 - 10.0MHz 16-QAM - RB Size 50)

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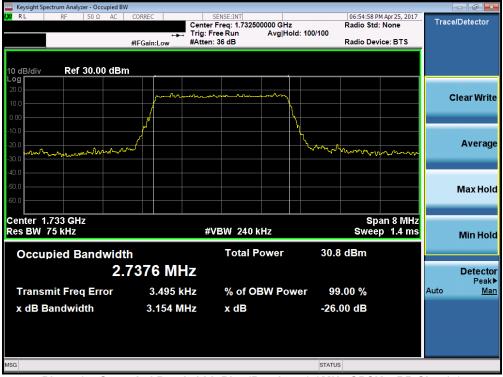
Plot 7-13. Occupied Bandwidth Plot (Band 4 - 1.4MHz QPSK - RB Size 6)



Plot 7-14. Occupied Bandwidth Plot (Band 4 – 1.4MHz 16-QAM – RB Size 6)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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Plot 7-15. Occupied Bandwidth Plot (Band 4 – 3.0MHz QPSK – RB Size 15)



Plot 7-16. Occupied Bandwidth Plot (Band 4 – 3.0MHz 16-QAM – RB Size 15)

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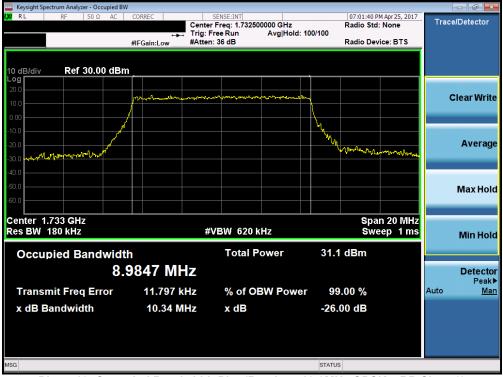
Plot 7-17. Occupied Bandwidth Plot (Band 4 - 5.0MHz QPSK - RB Size 25)



Plot 7-18. Occupied Bandwidth Plot (Band 4 – 5.0MHz 16-QAM – RB Size 25)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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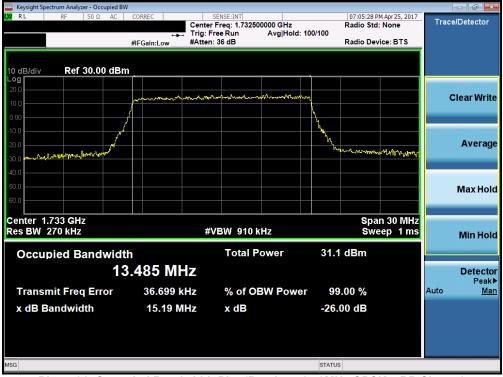
Plot 7-19. Occupied Bandwidth Plot (Band 4 - 10.0MHz QPSK - RB Size 50)



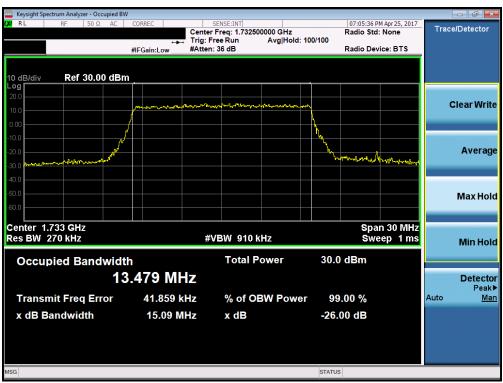
Plot 7-20. Occupied Bandwidth Plot (Band 4 - 10.0MHz 16-QAM - RB Size 50)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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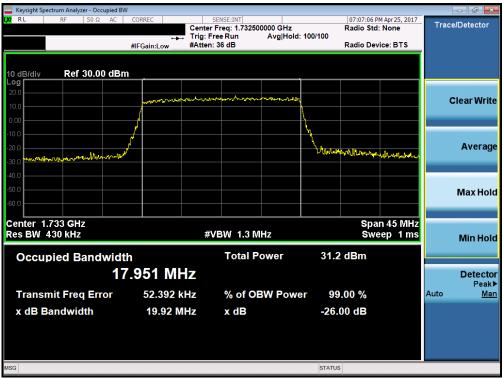
Plot 7-21. Occupied Bandwidth Plot (Band 4 - 15.0MHz QPSK - RB Size 75)



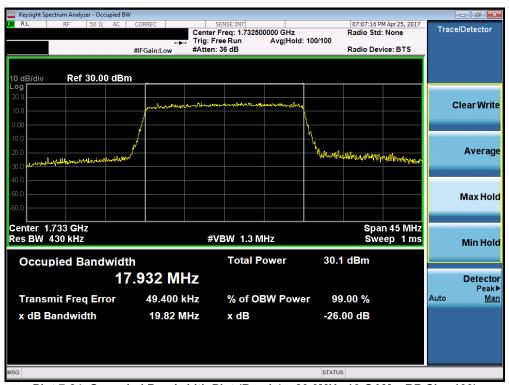
Plot 7-22. Occupied Bandwidth Plot (Band 4 - 15.0MHz 16-QAM - RB Size 75)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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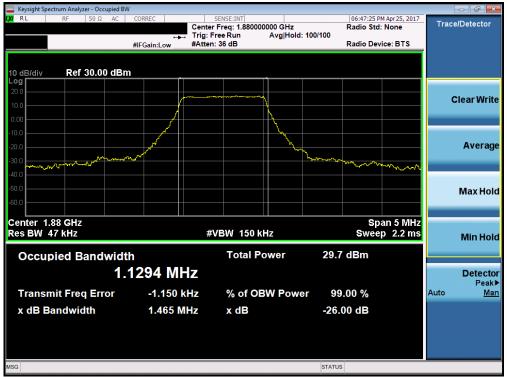
Plot 7-23. Occupied Bandwidth Plot (Band 4 – 20.0MHz QPSK – RB Size 100)



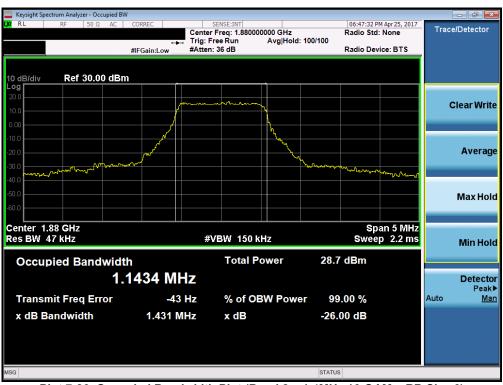
Plot 7-24. Occupied Bandwidth Plot (Band 4 – 20.0MHz 16-QAM – RB Size 100)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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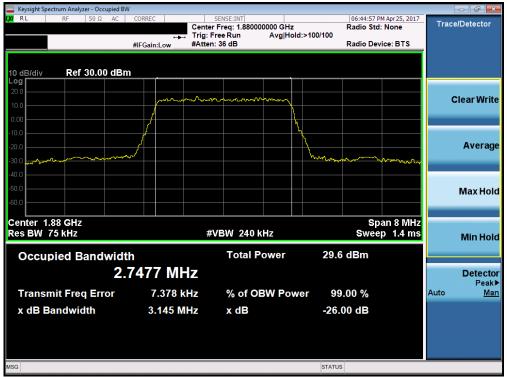
Plot 7-25. Occupied Bandwidth Plot (Band 2 - 1.4MHz QPSK - RB Size 6)



Plot 7-26. Occupied Bandwidth Plot (Band 2 - 1.4MHz 16-QAM - RB Size 6)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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Plot 7-27. Occupied Bandwidth Plot (Band 2 - 3.0MHz QPSK - RB Size 15)



Plot 7-28. Occupied Bandwidth Plot (Band 2 - 3.0MHz 16-QAM - RB Size 15)

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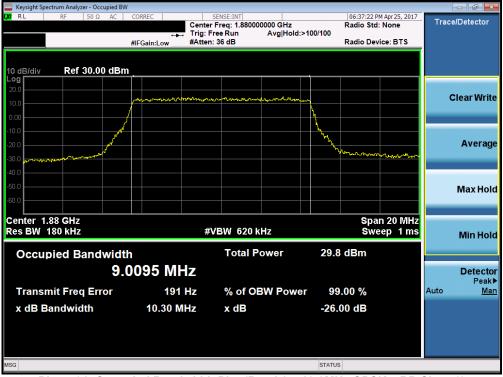
Plot 7-29. Occupied Bandwidth Plot (Band 2 - 5.0MHz QPSK - RB Size 25)



Plot 7-30. Occupied Bandwidth Plot (Band 2 - 5.0MHz 16-QAM - RB Size 25)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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Plot 7-31. Occupied Bandwidth Plot (Band 2 - 10.0MHz QPSK - RB Size 50)



Plot 7-32. Occupied Bandwidth Plot (Band 2 - 10.0MHz 16-QAM - RB Size 50)

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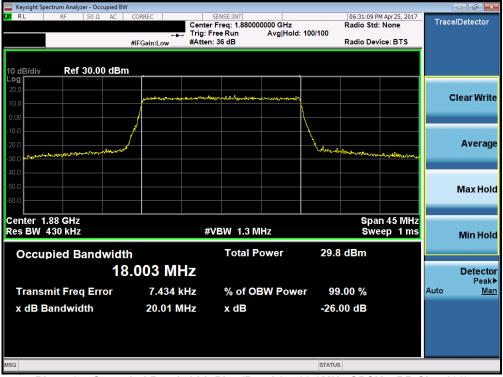
Plot 7-33. Occupied Bandwidth Plot (Band 2 - 15.0MHz QPSK - RB Size 75)



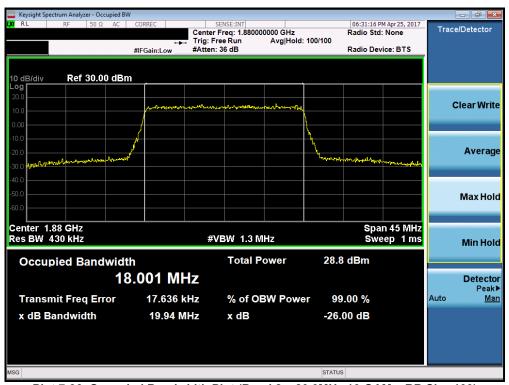
Plot 7-34. Occupied Bandwidth Plot (Band 2 - 15.0MHz 16-QAM - RB Size 75)

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Plot 7-35. Occupied Bandwidth Plot (Band 2 - 20.0MHz QPSK - RB Size 100)



Plot 7-36. Occupied Bandwidth Plot (Band 2 - 20.0MHz 16-QAM - RB Size 100)

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#### **Spurious and Harmonic Emissions at Antenna Terminal** 7.3 §2.1051 §22.917(a) §24.238(a) §27.53(g) §27.53(h)

### **Test Overview**

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is  $43 + \log_{10}(P_{IWatts1})$ , where P is the transmitter power in Watts.

### **Test Procedure Used**

KDB 971168 D01 v02r02 - Section 6.0

### **Test Settings**

- 1. Start frequency was set to 30MHz and stop frequency was set to at least 10 \* the fundamental frequency (separated into at least two plots per channel)
- 2. Detector = RMS
- 3. Trace mode = trace average
- 4. Sweep time = auto couple
- 5. The trace was allowed to stabilize
- 6. Please see test notes below for RBW and VBW settings

### Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

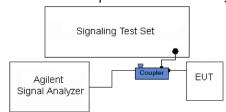


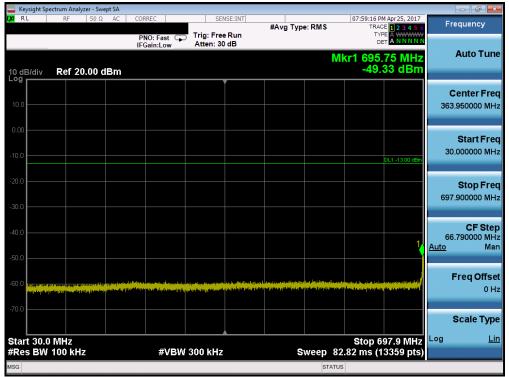
Figure 7-2. Test Instrument & Measurement Setup

### **Test Notes**

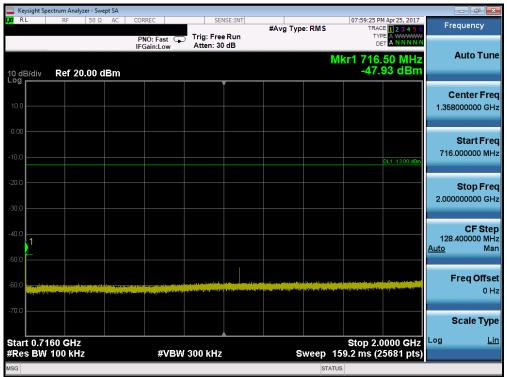
Compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kHz or greater for frequencies less than 1 GHz and 1 MHz or greater for frequencies greater than 1 GHz. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

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Plot 7-37. Conducted Spurious Plot (Band 17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

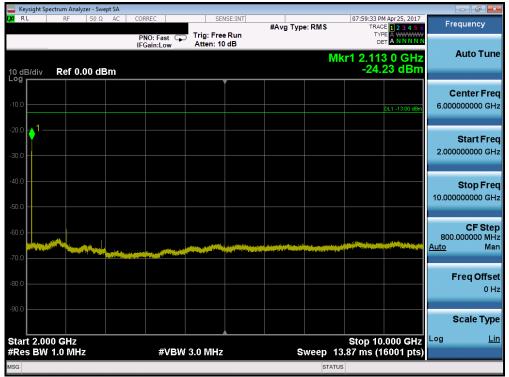


Plot 7-38. Conducted Spurious Plot (Band 17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

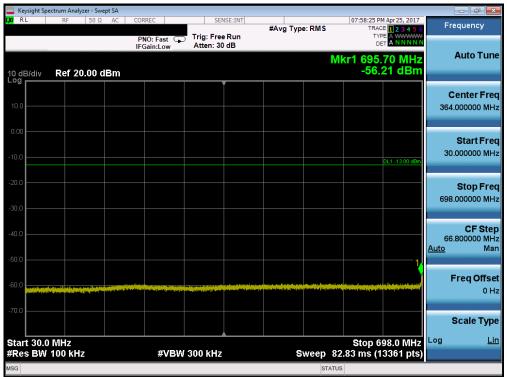
FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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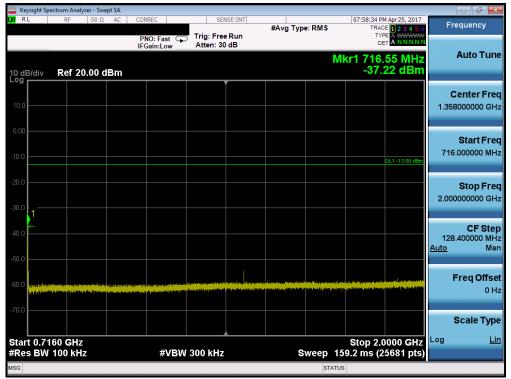
Plot 7-39. Conducted Spurious Plot (Band 17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)



Plot 7-40. Conducted Spurious Plot (Band 17 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

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			Quality Manager	
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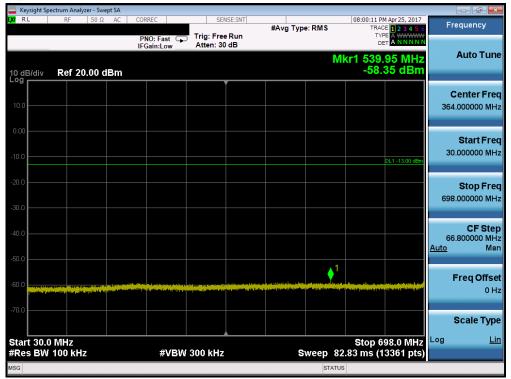
Plot 7-41. Conducted Spurious Plot (Band 17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)



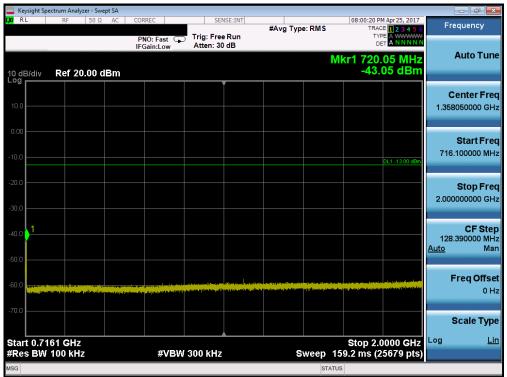
Plot 7-42. Conducted Spurious Plot (Band 17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Plot 7-43. Conducted Spurious Plot (Band 17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-44. Conducted Spurious Plot (Band 17 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	ISUNG	Approved by: Quality Manager
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Plot 7-45. Conducted Spurious Plot (Band 17 – 5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)



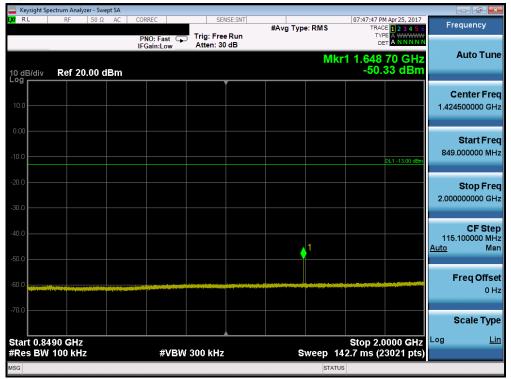
Plot 7-46. Conducted Spurious Plot (Band 5 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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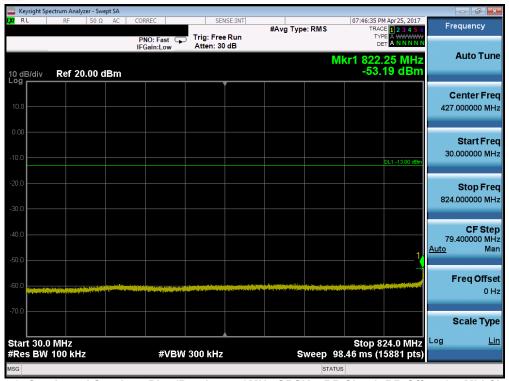
Plot 7-47. Conducted Spurious Plot (Band 5 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)



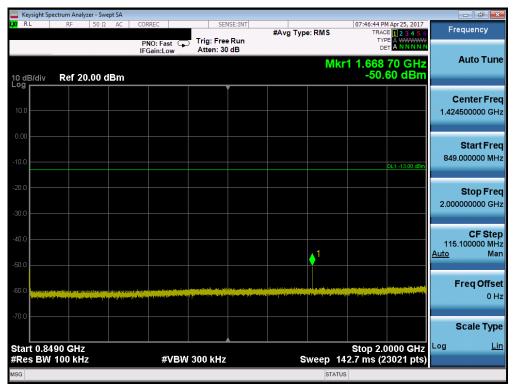
Plot 7-48. Conducted Spurious Plot (Band 5 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Plot 7-49. Conducted Spurious Plot (Band 5 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)



Plot 7-50. Conducted Spurious Plot (Band 5 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager	
Test Report S/N:	Test Dates:	EUT Type:		Daga 40 of 112	
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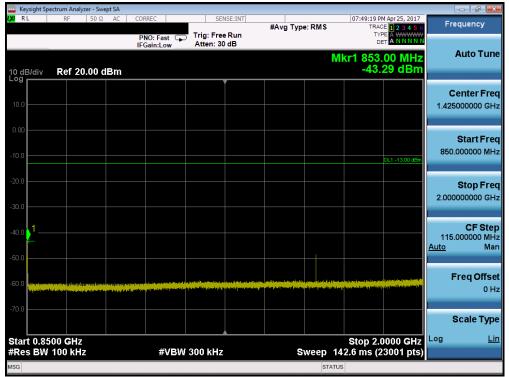
Plot 7-51. Conducted Spurious Plot (Band 5 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)



Plot 7-52. Conducted Spurious Plot (Band 5 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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Plot 7-53. Conducted Spurious Plot (Band 5 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-54. Conducted Spurious Plot (Band 5 - 5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

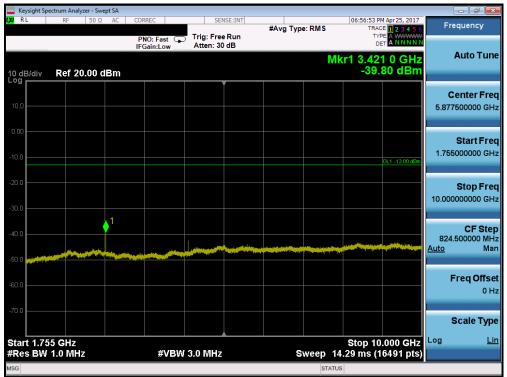
FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Dogg 40 of 112
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Plot 7-55. Conducted Spurious Plot (Band 4 – 3.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

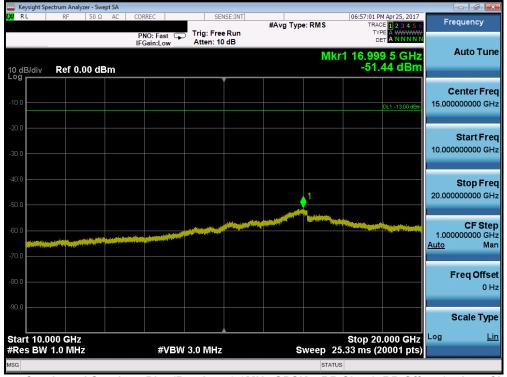


Plot 7-56. Conducted Spurious Plot (Band 4 – 3.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

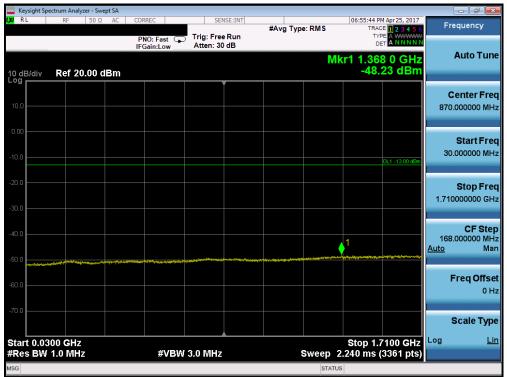
el BC7	@ PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT		Approved by:
FCC ID: A3LSMJ330F	TATIATION CAUSINST DAT	(CERTIFICATION)	SAMSUNG	Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Dog 42 of 112
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Plot 7-57. Conducted Spurious Plot (Band 4 – 3.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

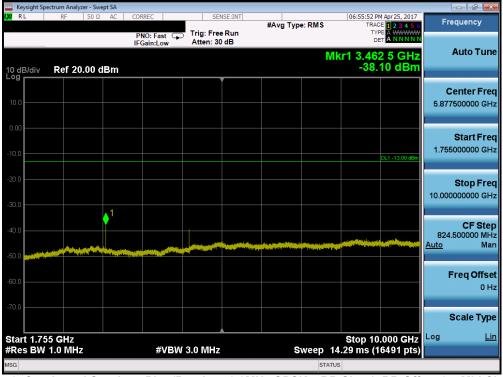


Plot 7-58. Conducted Spurious Plot (Band 4 - 3.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	Approved by:  Quality Manager
		Quality Manager
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Plot 7-59. Conducted Spurious Plot (Band 4 - 3.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

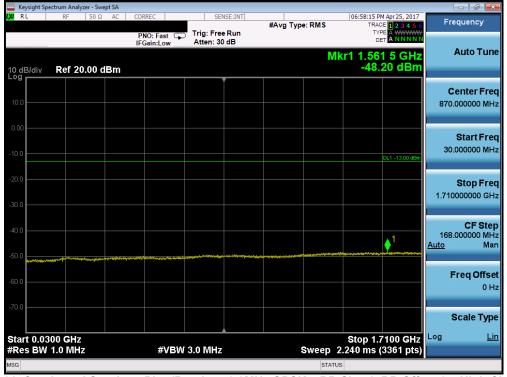


Plot 7-60. Conducted Spurious Plot (Band 4 - 3.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:
		(OEKTH IOATION)		Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Dog 45 of 112
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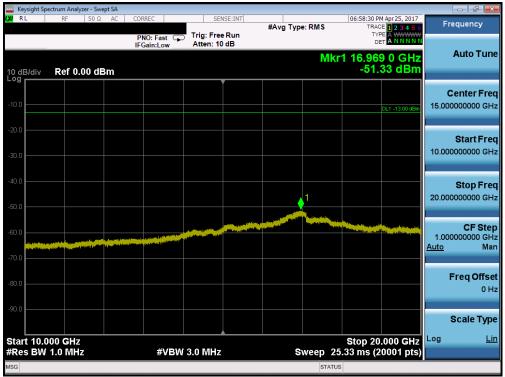
Plot 7-61. Conducted Spurious Plot (Band 4 - 3.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



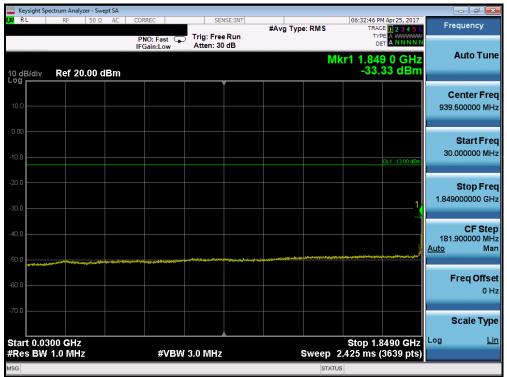
Plot 7-62. Conducted Spurious Plot (Band 4 – 3.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
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Plot 7-63. Conducted Spurious Plot (Band 4 - 3.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-64. Conducted Spurious Plot (Band 2 - 20.0MHz QPSK - RB Size 1, RB Offset 0- Low Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	ISUNG	Approved by: Quality Manager
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Plot 7-65. Conducted Spurious Plot (Band 2 - 20.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)



Plot 7-66. Conducted Spurious Plot (Band 2 - 20.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

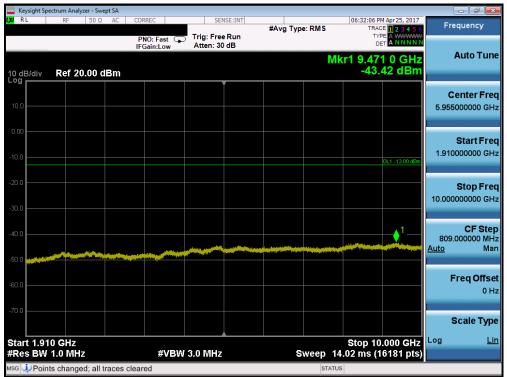
FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager
Test Report S/N:	Test Dates:	EUT Type:		Dags 40 of 112
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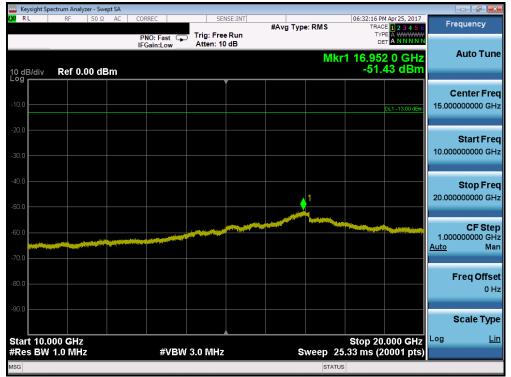
Plot 7-67. Conducted Spurious Plot (Band 2 - 20.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)



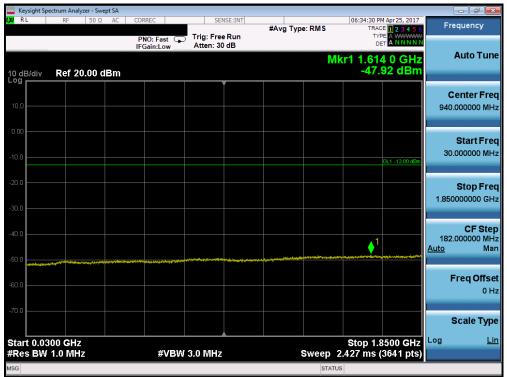
Plot 7-68. Conducted Spurious Plot (Band 2 - 20.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager	
Test Report S/N:	Test Dates:	EUT Type:		Dags 40 of 112	
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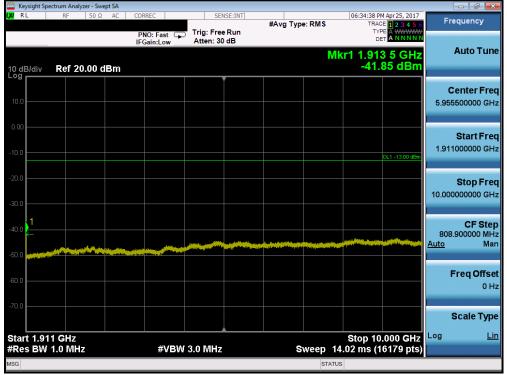
Plot 7-69. Conducted Spurious Plot (Band 2 - 20.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)



Plot 7-70. Conducted Spurious Plot (Band 2 - 20.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by:  Quality Manager	
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Plot 7-71. Conducted Spurious Plot (Band 2 - 20.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-72. Conducted Spurious Plot (Band 2 - 20.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ330F	PCTEST	FCC Pt. 22, 24, & 27 LTE MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager	
Test Report S/N:	Test Dates:	EUT Type:		Daga E1 of 112	
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